

<b>Notice of References Cited</b>	Application/Control No. 10/760,012	Applicant(s)/Patent Under Reexamination SUGAHARA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0033674 A1	10-2001	Chen et al.	382/100
*	B	US-2002/0009208 A1	01-2002	Alattar et al.	382/100
*	C	US-2002/0051560 A1	05-2002	Donescu et al.	382/100
*	D	US-2002/0083324 A1	06-2002	Hirai, Jun	713/176
*	E	US-6,449,380 B1	09-2002	Acharya et al.	382/100
*	F	US-2002/0157005 A1	10-2002	Brunk et al.	713/176
*	G	US-6,512,837 B1	01-2003	Ahmed, Farid	382/100
*	H	US-2003/0161496 A1	08-2003	HAYASHI et al.	382/100
*	I	US-6,971,010 B1	11-2005	Abdel-Mottaleb, Mohamed	713/176
*	J	US-6,990,213 B2	01-2006	Donescu, Ioana	382/100
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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